

AUTOMOTIVE GRADE

AUIRF1405ZS AUIRF1405ZL

Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

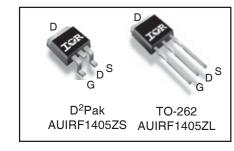
Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low onresistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

HEXFET® Power MOSFET



V _{(BR)DSS}	55V		
R _{DS(on)} max.	4.9m $Ω$		
I _D	150A		



G	D	S
Gate	Drain	Source

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	150	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	110	A
I _{DM}	Pulsed Drain Current ①	600	1
P _D @T _C = 25°C	Power Dissipation	230	W
	Linear Derating Factor	1.5	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	٧
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	270	mJ
E _{AS} (tested)	Single Pulse Avalanche Energy Tested Value ®	420]
I _{AR}	Avalanche Current ①	See Fig.12a, 12b, 15, 16	Α
E _{AR}	Repetitive Avalanche Energy ©		mJ
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	1
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		0.65	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount, steady state)♡		40	

HEXFET® is a registered trademark of International Rectifier.

^{*}Qualification standards can be found at http://www.irf.com/

Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.049		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		3.7	4.9	mΩ	V _{GS} = 10V, I _D = 75A ③
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Transconductance	88			S	$V_{DS} = 25V, I_D = 75A$
I _{DSS}	Drain-to-Source Leakage Current			20	μΑ	$V_{DS} = 55V, V_{GS} = 0V$
				250		$V_{DS} = 55V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			200	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage		_	-200		V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	_ ya			(o opeomea,
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	Q_g	Total Gate Charge		120	180		I _D = 75A
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Q_{gs}	Gate-to-Source Charge		31		nC	$V_{DS} = 44V$
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	Q_{gd}	Gate-to-Drain ("Miller") Charge		46			V _{GS} = 10V ③
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	t _{d(on)}	Turn-On Delay Time	_	18			$V_{DD} = 25V$
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	t _r	Rise Time		110			I _D = 75A
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	t _{d(off)}	Turn-Off Delay Time		48		ns	$R_G = 4.4\Omega$
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	t _f	Fall Time		82			V _{GS} = 10V ③
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	L _D	Internal Drain Inductance	l	4.5			Between lead,
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$						nΗ	6mm (0.25in.)
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	L _S	Internal Source Inductance		7.5			from package
							and center of die contact
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	C _{iss}	Input Capacitance		4780			V _{GS} = 0V
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	C _{oss}	Output Capacitance		770			V _{DS} = 25V
C_{oss} Output Capacitance 600 $V_{GS} = 0V$, $V_{DS} = 44V$, $f = 1.0MHz$	C_{rss}	Reverse Transfer Capacitance	I	410		pF	f = 1.0MHz
	C _{oss}	Output Capacitance		2730			$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
C_{oss} eff. Effective Output Capacitance — 910 — $V_{GS} = 0V$, $V_{DS} = 0V$ to 44V $\textcircled{*}$	C _{oss}	Output Capacitance		600			$V_{GS} = 0V, V_{DS} = 44V, f = 1.0MHz$
	C _{oss} eff.	Effective Output Capacitance		910			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 44V $

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			75		MOSFET symbol
	(Body Diode)				Α	showing the
I _{SM}	Pulsed Source Current			600		integral reverse
	(Body Diode) ①					p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$, $I_S = 75A$, $V_{GS} = 0V$ ③
t _{rr}	Reverse Recovery Time		30	46		$T_J = 25^{\circ}C, I_F = 75A, V_{DD} = 25V$
Q_{rr}	Reverse Recovery Charge		30	45	nC	di/dt = 100A/µs ③
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

Notes:

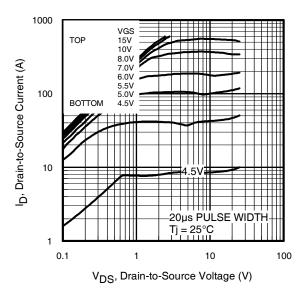
- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Limited by T_{Jmax} , starting T_J = 25°C, L = 0.10mH R_G = 25 Ω , I_{AS} = 75A, V_{GS} =10V. Part not recommended for use above this value.
- $\ \, \oplus \, \, C_{oss}$ eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- S Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- © This value determined from sample failure population, starting T_J = 25°C, L = 0.10mH, R_G = 25 Ω , I_{AS} = 75A, V_{GS} =10V.
- This is applied to D²Pak, when mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.

Qualification Information[†]

		Automotive (per AEC-Q101) ††				
		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture Sensitivity	Majatuwa Canalkinitu Laural		N/A			
Woisture Sensitivity	y Levei	D ² Pak MSL1				
	Machine Model		Class M4 (425V)			
			AEC-Q101-002			
	Human Body Model	Class H1C (2000V)				
ESD		AEC-Q101-001				
	Charged Device		Class C5 (1125V)			
Model		AEC-Q101-005				
RoHS Compliant	,	Yes				

[†] Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

^{††} Exceptions to AEC-Q101 requirements are noted in the qualification report.



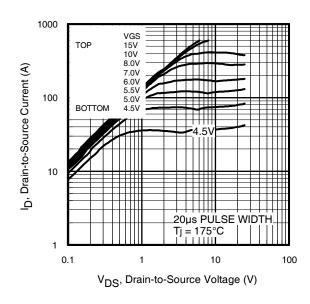
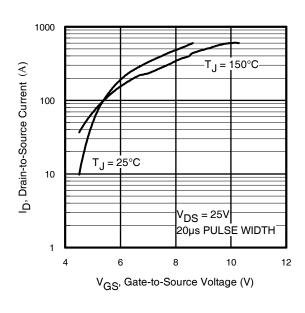


Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics



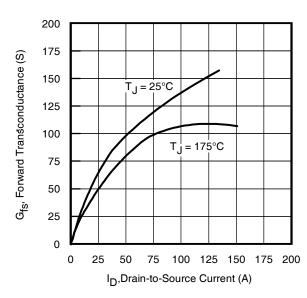
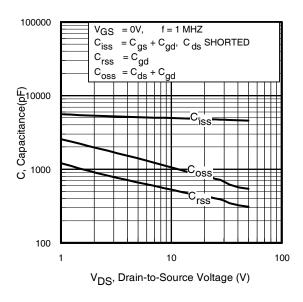


Fig 3. Typical Transfer Characteristics

Fig 4. Typical Forward Transconductance vs. Drain Current



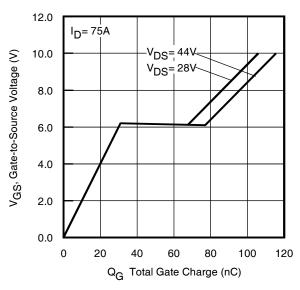
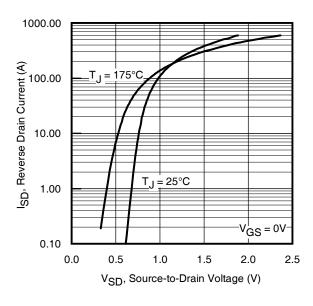


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



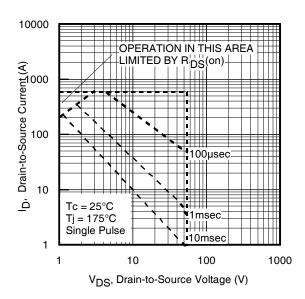
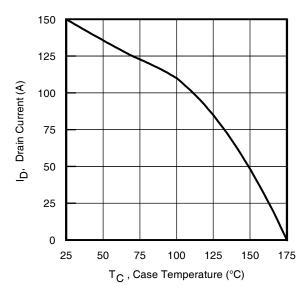


Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area



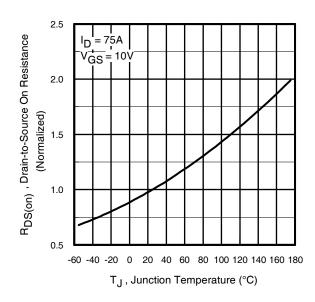


Fig 9. Maximum Drain Current vs. Case Temperature

Fig 10. Normalized On-Resistance vs. Temperature

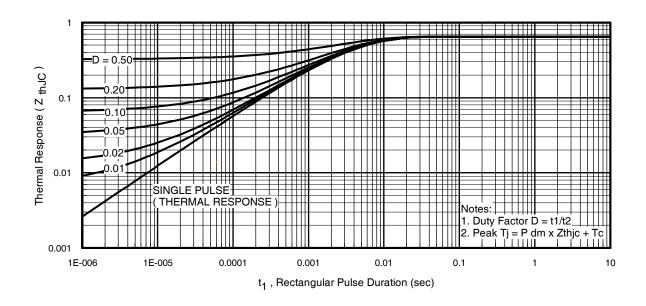


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

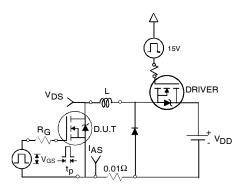


Fig 12a. Unclamped Inductive Test Circuit

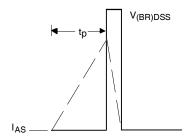


Fig 12b. Unclamped Inductive Waveforms

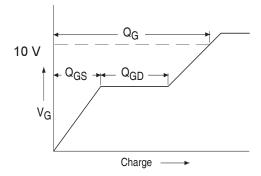
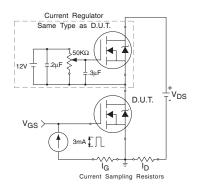


Fig 13a. Basic Gate Charge Waveform



 E_{AS} , Single Pulse Avalanche Energy (mJ) Р TOP 31A 400 53A BOTTOM 75A 300 200 100 0 25 50 100 125 175 150 Starting T_{.J}, Junction Temperature (°C)

Fig 12c. Maximum Avalanche Energy vs. Drain Current

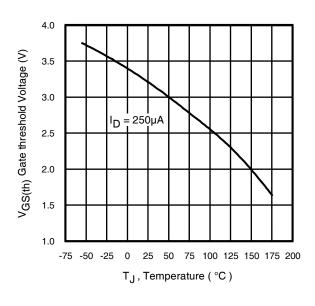


Fig 14. Threshold Voltage vs. Temperature

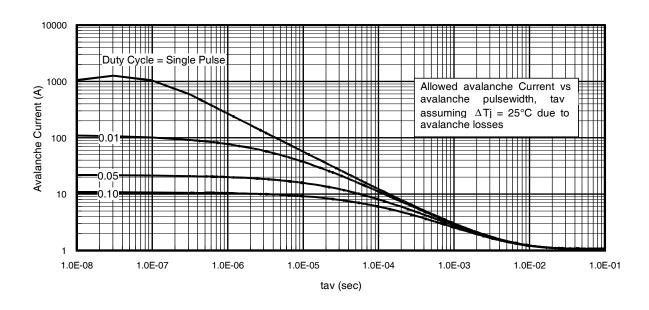


Fig 15. Typical Avalanche Current vs. Pulsewidth

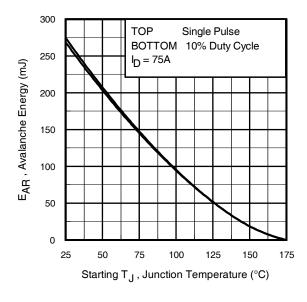


Fig 16. Maximum Avalanche Energy vs. Temperature

8

Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
- Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
- Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. $P_{D \text{ (ave)}}$ = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).
 - t_{av} = Average time in avalanche.
 - D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{th,JC}(D, t_{av})$ = Transient thermal resistance, see figure 11)

$$\begin{split} P_{D~(ave)} &= 1/2~(~1.3 \cdot BV \cdot I_{aV}) = \triangle T/~Z_{thJC} \\ I_{av} &= 2\triangle T/~[1.3 \cdot BV \cdot Z_{th}] \\ E_{AS~(AR)} &= P_{D~(ave)} \cdot t_{av} \end{split}$$

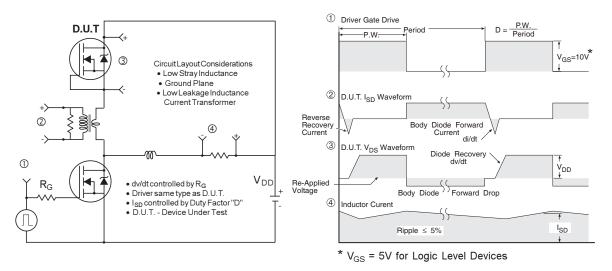


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

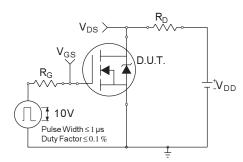


Fig 18a. Switching Time Test Circuit

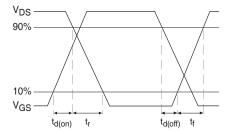
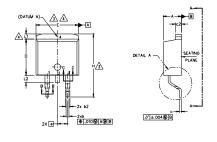


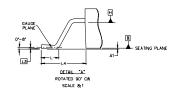
Fig 18b. Switching Time Waveforms

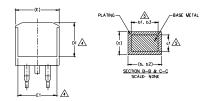
D²Pak (TO-263AB) Package Outline

Dimensions are shown in millimeters (inches)









S			Ŋ		
M B O L	MILLIM	ETERS	INC	HES	O T E S
L	MIN.	MAX.	MIN.	MAX.	E S
Α	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
b	0.51	0.99	.020	.039	
b1	0.51	0.89	.020	.035	5
b2	1,14	1.78	.045	.070	
ь3	1,14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1,14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270		4
E	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245		4
e	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1,78	2.79	.070	.110	
L1	-	1.65	-	.066	4
L2	-	1.78	-	.070	
L3	0.25	BSC	.010	.010 BSC	
L4	4.78	5.28	.188	.208	

- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SDE. THESE DIMENSIONS ARE MEASURED AT THE OUTNOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- SDIMENSION 61 AND 61 APPLY TO BASE WETAL ONLY.
- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8, OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

D²Pak (TO-263AB) Part Marking Information

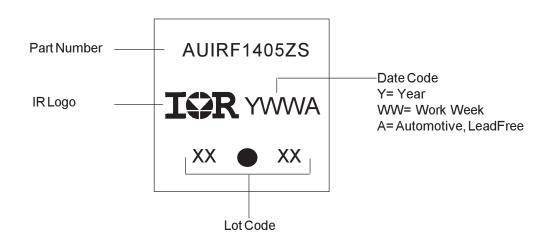
LEAD ASSIGNMENTS

DIODES

HEXFET

1.- ANODE (TWO DIE) / OPEN (ONE DIE)
2, 4,- CATHODE
3.- ANODE

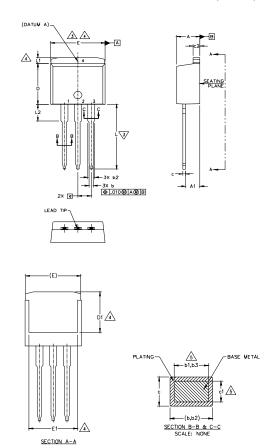
IGBTs. CoPACK



AUIRF1405ZS/L

TO-262 Package Outline

Dimensions are shown in millimeters (inches)



S		N			
M B O	MILLIM	ETERS	INC	HES	O T E S
L	MIN.	MAX.	MIN.	MAX.	S
Α	4.06	4.83	.160	.190	
A1	2.03	3.02	.080	.119	
ь	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
ь2	1.14	1.78	.045	.070	
ь3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	_	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245		4
е	2.54	BSC	.100 BSC		
L	13.46	14.10	.530	.555	
∟ 1	_	1.65	_	.065	4
L2	3.56	3.71	.140	.146	

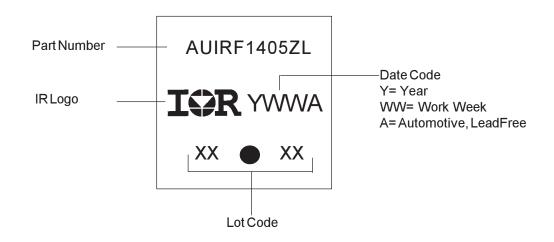
- NOTES:

 1. DIMENSIONING AND TOLERANGING PER ASME Y14.5M-199
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- ▲ DINENSION D & E DO NOT NOLLUDE WOLD FLASH. WOLD FLASH SHALL NOT EXCEE 0.127 [.006*] PER SDE, THESE DINENSIONS ARE WEASURED AT THE OUTWOST EXTREMES OF THE PLASTIC ROOM.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E. L1. D1 &
- CONTROLLING DIVENSION: INCH.
- 7.- DUTLINE CONFORM TO JEDEC TD-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE

LEAD ASSIGNMENTS

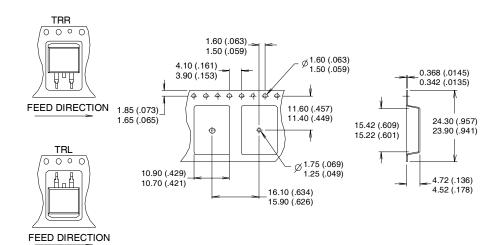
- 1.- GATE
- 2 COLLECTOR 3.- EMITTER
- 4.- COLLECTOR
- HEXFET DIQUI
- 2.- DRAIN 2, 4.- CATHODE 3.- SOURCE 3.- ANODE

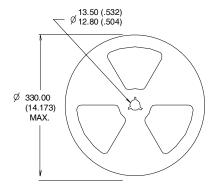
TO-262 Part Marking Information

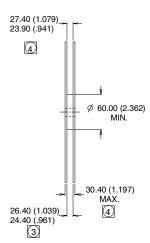


D²Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)







NOTES:

- ONES:

 COMFORMS TO EIA-418.

 CONTROLLING DIMENSION: MILLIMETER.

 DIMENSION MEASURED @ HUB.

 INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Ordering Information

Base part	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRF1405ZL	TO-262	Tube	50	AUIRF1405ZL
AUIRF1405ZS	D2Pak	Tube	50	AUIRF1405ZS
		Tape and Reel Left	800	AUIRF1405ZSTRL
		Tape and Reel Right	800	AUIRF1405ZSTRR

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